

## MOS FIELD EFFECT TRANSISTOR 2SK3115

## SWITCHING N-CHANNEL POWER MOS FET INDUSTRIAL USE

#### **DESCRIPTION**

The 2SK3115 is N-Channel DMOS FET device that features a low gate charge and excellent switching haracteristics, and designed for high voltage applications such as switching power supply, AC adapter.

#### **FEATURES**

- Low gate charge
   QG = 26 nC TYP. (VDD = 450 V, VGS = 10 V, ID = 6.0 A)
- Gate voltage rating ±30 V
- Low on-state resistance
   RDS(on) = 1.2 Ω MAX. (VGS = 10 V, ID = 3.0 A)
- · Avalanche capability ratings

#### ORDERING INFORMATION

| PART NUMBER | PACKAGE         |
|-------------|-----------------|
| 2SK3115     | Isolated TO-220 |

★ (Isolated TO-220)



#### ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

| Drain to Source Voltage (Vss = 0 V) | VDSS            | 600         | V  |
|-------------------------------------|-----------------|-------------|----|
| Gate to Source Voltage (Vps = 0 V)  | Vgss            | ±30         | V  |
| Drain Current (DC) (Tc = 25°C)      | ID(DC)          | ±6.0        | Α  |
| Drain Current (pulse) Note1         | D(pulse)        | ±24         | Α  |
| Total Power Dissipation (TA = 25°C) | P <sub>T1</sub> | 2.0         | W  |
| Total Power Dissipation (Tc = 25°C) | P <sub>T2</sub> | 35          | W  |
| Channel Temperature                 | Tch             | 150         | °C |
| Storage Temperature                 | Tstg            | -55 to +150 | °C |
| Single Avalanche Current Note2      | las             | 6.0         | Α  |
| Single Avalanche Energy Note2       | Eas             | 24          | mJ |

**Notes 1.** PW  $\leq$  10  $\mu$ s, Duty Cycle  $\leq$  1%

**2.** Starting  $T_{ch} = 25^{\circ}C$ ,  $V_{DD} = 150 \text{ V}$ ,  $R_{G} = 25 \Omega$ ,  $V_{GS} = 20 \rightarrow 0 \text{ V}$ 

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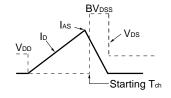


#### **ELECTRICAL CHARACTERISTICS (TA = 25°C)**

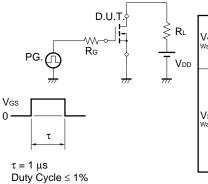
| Characteristics                     | Symbol               | Test Conditions                                 | MIN. | TYP. | MAX. | Unit |
|-------------------------------------|----------------------|---|------|------|------|------|
| Zero Gate Voltage Drain Current     | Ioss                 | V <sub>DS</sub> = 600 V, V <sub>GS</sub> = 0 V  |      |      | 100  | μΑ   |
| Gate Leakage Current                | Igss                 | VGS = ±30 V, VDS = 0 V                          |      |      | ±100 | nA   |
| Gate Cut-off Voltage                | V <sub>GS(off)</sub> | V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA   | 2.5  |      | 3.5  | V    |
| Forward Transfer Admittance         | yfs                  | V <sub>DS</sub> = 10 V, I <sub>D</sub> = 3.0 A  | 2.0  |      |      | S    |
| Drain to Source On-state Resistance | RDS(on)              | Vgs = 10 V, ID = 3.0 A                          |      | 0.9  | 1.2  | Ω    |
| Input Capacitance                   | Ciss                 | V <sub>DS</sub> = 10 V                          |      | 1100 |      | pF   |
| Output Capacitance                  | Coss                 | Vgs = 0 V                                       |      | 200  |      | pF   |
| Reverse Transfer Capacitance        | Crss                 | f = 1 MHz                                       |      | 20   |      | pF   |
| Turn-on Delay Time                  | td(on)               | V <sub>DD</sub> = 150 V, I <sub>D</sub> = 3.0 A |      | 18   |      | ns   |
| Rise Time                           | <b>t</b> r           | V <sub>GS(on)</sub> = 10 V                      |      | 12   |      | ns   |
| Turn-off Delay Time                 | t <sub>d(off)</sub>  | $R_G = 10 \Omega$ , $R_L = 50 \Omega$           |      | 50   |      | ns   |
| Fall Time                           | tr                   |   |      | 15   |      | ns   |
| Total Gate Charge                   | Q <sub>G</sub>       | V <sub>DD</sub> = 450 V                         |      | 26   |      | nC   |
| Gate to Source Charge               | Qgs                  | Vgs = 10 V                                      |      | 6    |      | nC   |
| Gate to Drain Charge                | Q <sub>GD</sub>      | ID = 6.0 A                                      |      | 10   |      | nC   |
| Body Diode Forward Voltage          | V <sub>F(S-D)</sub>  | IF = 6.0 A, VGS = 0 V                           |      | 1.0  |      | V    |
| Reverse Recovery Time               | trr                  | IF = 6.0 A, VGS = 0 V                           |      | 1.4  |      | μs   |
| Reverse Recovery Charge             | Qrr                  | di/dt = 50 A/μs                                 |      | 6.5  |      | μC   |

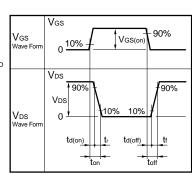
#### \* TEST CIRCUIT 1 AVALANCHE CAPABILITY

## $\begin{array}{c} \text{D.U.T.} \\ \text{RG} = 25 \ \Omega \\ \text{VGS} = 20 \rightarrow 0 \ \text{V} \end{array} \begin{array}{c} \text{PG.} \\ \text{PS.} \\ \text{PS.} \\ \text{M.S.} \end{array} \begin{array}{c} \text{D.U.T.} \\ \text{I.I.} \\ \text{VDD} \\ \text{M.S.} \end{array}$

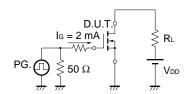


#### **TEST CIRCUIT 2 SWITCHING TIME**

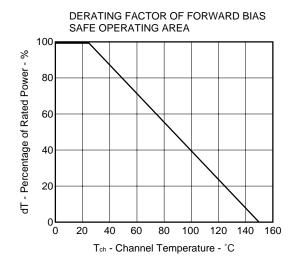


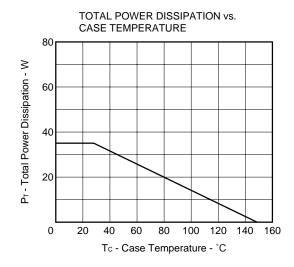


#### **TEST CIRCUIT 3 GATE CHARGE**



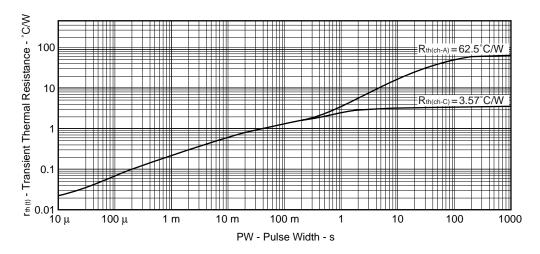
#### **★ TYPICAL CHARACTERISTICS (TA = 25°C)**





# FORWARD BIAS SAFE OPERATING AREA 100 10 | Dipulse | Di

#### TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



25

20

15

10

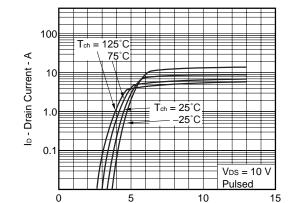
0

lo - Drain Current - A

### DRAIN TO SOURCE VOLTAGE Pulsed

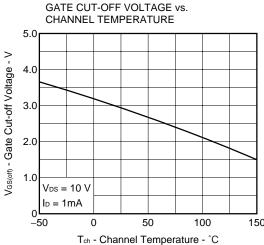
DRAIN CURRENT vs.

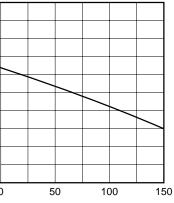
10 20 30 V<sub>DS</sub> - Drain to Source Voltage - V

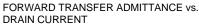


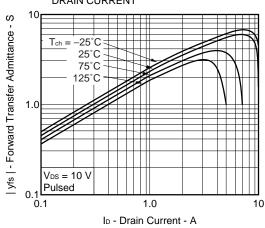
FORWARD TRANSFER CHARACTERISTICS

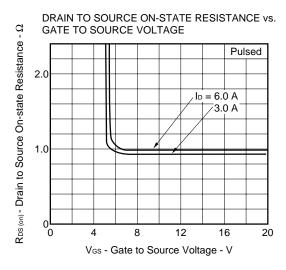
V<sub>GS</sub> - Gate to Source Voltage - V

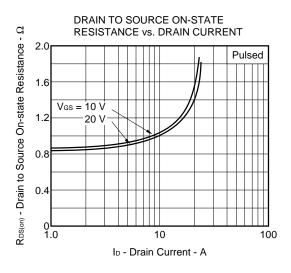


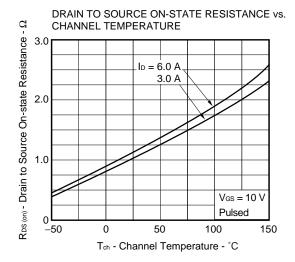




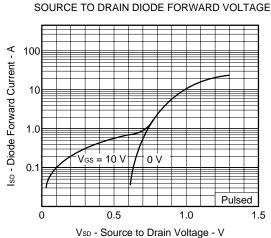


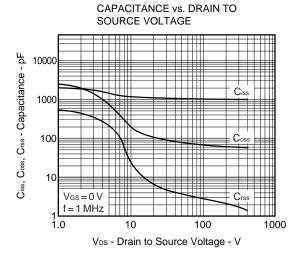


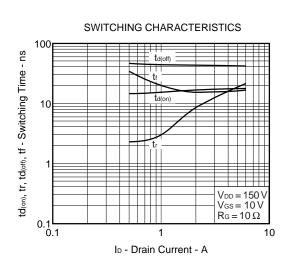


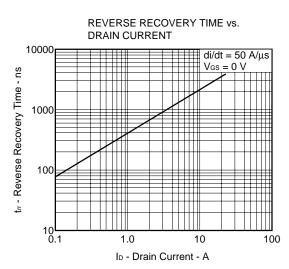


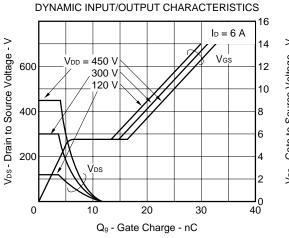




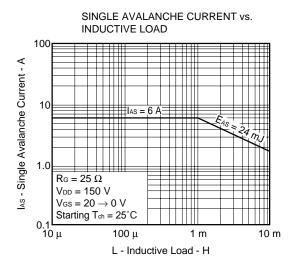


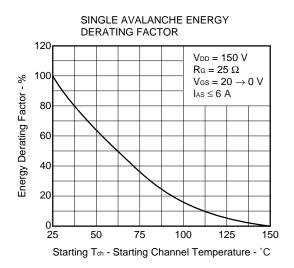






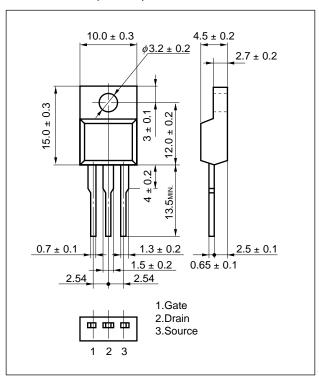
Ves - Gate to Source Voltage - V



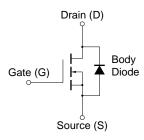


#### **PACKAGE DRAWING (Unit: mm)**

#### Isolated TO-220(MP-45F)



#### **EQUIVALENT CIRCUIT**



**Remark** Strong electric field, when exposed to this device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it once, when it has occurred.

**NEC** 2SK3115

[MEMO]

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